

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10516334	HOPKINS ET AL.
Examiner	Art Unit	
Lee, Shun	2884	

SEARCHED

Class	Subclass	Date	Examiner
250	345	6/14/2007	/SL/
Above	UPDATED	2/4/2008	/SL/

SEARCH NOTES

Search Notes	Date	Examiner
EAST (US-PGPUB, USPAT, USOCR, EPO, JPO, IBM_TDB) - See Search History Printout	2/4/2008	/SL/

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner